

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/784,327	BURDENKO, MICHAEL N.	
		Examiner	Art Unit	
		Huan H. Tran	2861	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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**FOREIGN PATENT DOCUMENTS**

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	N	JP 56-157389	12-1981	Japan	Yabuki et al	B41J011/02
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